 ch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,238	KAN, MAKIKO
Examiner	Art Unit

2825

Sun J. Lin

	SEARCHED				
Class	Subclass	Date	Examiner		
716	1	8/11/2005	JSL		
			:		
		-			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
				
			<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	8/11/2005	JSL	
		-	
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